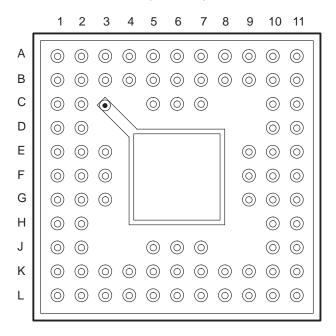
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- Member of the Texas Instruments Widebus™ Family
- Advanced BiCMOS Technology
- Released as DSCC SMD (Standard Microcircuit Drawing) 5962-9650901QXA
- Independent Asynchronous Inputs and Outputs
- Two Separate 512 × 18 FIFOs Buffering Data in Opposite Directions

- Programmable Almost-Full/Almost-Empty Flag
- Empty, Full, and Half-Full Flags
- Fast Access Times of 12 ns With a 50-pF Load and Simultaneous Switching Data Outputs
- Packaged in 84-Pin Ceramic Pin Grid Array

#### GB PACKAGE (TOP VIEW)



#### description

A FIFO memory is a storage device that allows data to be written into and read from its array at independent data rates. The SN54ABT7820 is arranged as two 512  $\times$  18-bit FIFOs for high speed and fast access times. It processes data at rates up to 40 MHz, with access times of 18 ns in a bit-parallel format.

The SN54ABT7820 consists of bus transceiver circuits, two  $512 \times 18$  FIFOs, and control circuitry arranged for multiplexed transmission of data directly from the data bus or from the internal FIFO memories. Enable inputs GAB and GBA control the transceiver functions. The SAB and SBA control inputs select whether real-time or stored data is transferred. The circuitry used for select control eliminates the typical decoding glitch that occurs in a multiplexer during the transition between stored and real-time data. Figure 1 illustrates the eight fundamental bus-management functions that can be performed with the SN54ABT7820.

The SN54ABT7820 is characterized for operation over the full military temperature range of -55°C to 125°C.



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

Widebus is a trademark of Texas Instruments.



# STROBED BIDIRECTIONAL FIRST-IN, FIRST-OUT MEMORY SGBS303E – AUGUST 1994 – REVISED APRIL 2000

## **Terminal Assignments**

TERMINAL	NAME	TERMINAL	NAME	TERMINAL	NAME	TERMINAL	NAME
A1	PENA	B11	FULLB	F9	NC	K2	A11
A2	GBA	C1	GND	F10	B6	K3	GND
A3	SBA	C2	HFA	F11	GND	K4	Vcc
A4	LDCKA	C5	UNCKB	G1	A5	K5	GND
A5	Vcc	C6	NC	G2	GND	K6	A17
A6	Vcc	C7	Vcc	G3	A4	K7	GND
A7	Vcc	C10	HFB	G9	B4	K8	VCC
A8	LDCKB	C11	GND	G10	GND	K9	GND
A9	SAB	D1	A1	G11	B5	K10	B10
A10	GAB	D2	A0	H1	A7	K11	В9
A11	AF/AEB	D10	В0	H2	GND	L1	A10
B1	FULLA	D11	B1	H10	GND	L2	A12
B2	AF/AEA	E1	А3	H11	B7	L3	A13
В3	RSTA	E2	A2	J1	A8	L4	A14
B4	GND	E3	Vсс	J2	Vcc	L5	A16
B5	EMPTYB	E9	Vcc	J5	A15	L6	B15
В6	UNCKA	E10	B2	J6	NC	L7	B16
В7	EMPTYA	E11	В3	J7	B17	L8	B14
B8	GND	F1	A6	J10	Vcc	L9	B13
B9	RSTB	F2	GND	J11	B8	L10	B12
B10	PENB	F3	NC	K1	A9	L11	B11



# STROBED BIDIRECTIONAL FIRST-IN, FIRST-OUT MEMORY SGBS303E - AUGUST 1994 - REVISED APRIL 2000

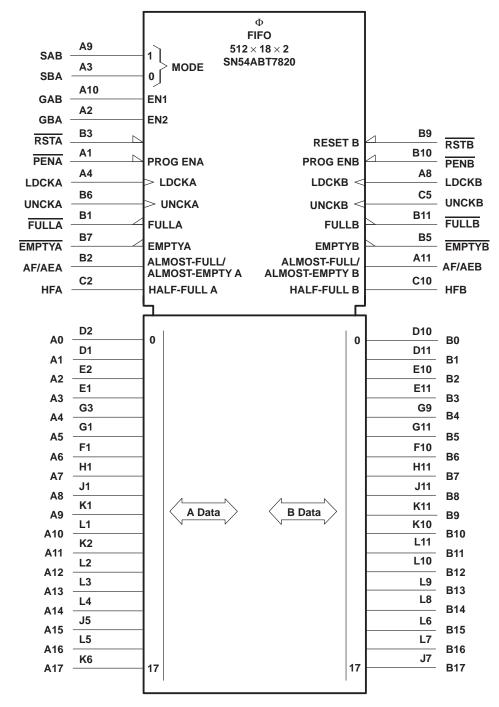
### **Terminal Functions**

TERMINAL NAME	I/O	DESCRIPTION
A0-A17	I/O	Port-A data. The 18-bit bidirectional data port for side A.
AF/AEA	0	FIFO A almost-full/almost-empty flag. Depth offset values can be programmed for AF/AEA, or the default value of 128 can be used for both the almost-empty offset (X) and the almost-full offset (Y). AF/AEA is high when FIFO A contains X or fewer words or (512 – Y) or more words. AF/AEA is set high after FIFO A is reset.
AF/AEB	0	FIFO B almost-full/almost-empty flag. Depth offset values can be programmed for AF/AEB, or the default value of 128 can be used for both the almost-empty offset (X) and the almost-full offset (Y). AF/AEB is high when FIFO B contains X or fewer words or (512 – Y) or more words. AF/AEB is set high after FIFO B is reset.
B0-B17	I/O	Port-B data. The 18-bit bidirectional data port for side B.
EMPTYA	0	FIFO A empty flag. EMPTYA is low when FIFO A is empty and is high when FIFO A is not empty. EMPTYA is set low after FIFO A is reset.
EMPTYB	0	FIFO B empty flag. EMPTYB is low when FIFO B is empty and is high when FIFO B is not empty. EMPTYB is set low after FIFO B is reset.
FULLA	0	FIFO A full flag. FULLA is low when FIFO A is full and is high when FIFO A is not full. FULLA is set high after FIFO A is reset.
FULLB	0	FIFO B full flag. FULLB is low when FIFO B is full and is high when FIFO B is not full. FULLB is set high after FIFO B is reset.
GAB	ı	Port-B output enable. B0 – B17 outputs are active when GAB is high and are in the high-impedance state when GAB is low.
GBA	ı	Port-A output enable. A0 – A17 outputs are active when GBA is high and are in the high-impedance state when GBA is low.
HFA	0	FIFO A half-full flag. HFA is high when FIFO A contains 256 or more words and is low when FIFO A contains 255 or fewer words. HFA is set low after FIFO A is reset.
HFB	0	FIFO B half-full flag. HFB is high when FIFO B contains 256 or more words and is low when FIFO B contains 255 or fewer words. HFB is set low after FIFO B is reset.
LDCKA	I	FIFO A load clock. Data is written into FIFO A on a low-to-high transition of LDCKA when FULLA is high. The first word written into an empty FIFO A is sent directly to the FIFO A data outputs.
LDCKB	ı	FIFO B load clock. Data is written into FIFO B on a low-to-high transition of LDCKB when FULLB is high. The first word written into an empty FIFO B is sent directly to the FIFO B data outputs.
PENA	I	FIFO A program enable. After reset and before a word is written into FIFO A, the binary value on A0-A7 is latched as an AF/AEA offset value when PENA is low and LDCKA is high.
PENB	I	FIFO B program enable. After reset and before a word is written into FIFO B, the binary value on B0-B7 is latched as an AF/AEB offset value when PENB is low and LDCKB is high.
RSTA	ı	FIFO A reset. A low level on RSTA resets FIFO A, forcing EMPTYA low, HFA low, FULLA high, and AF/AEA high.
RSTB	ı	FIFO B reset. A low level on RSTB resets FIFO B, forcing EMPTYB low, HFB low, FULLB high, and AF/AEB high.
SAB	I	Port-B read select. SAB selects the source of B0-B17 read data. A low level selects real-time data from A0-A17. A high level selects the FIFO A output.
SBA	I	Port-A read select. SBA selects the source of A0-A17 read data. A low level selects real-time data from B0 - B17. A high level selects the FIFO B output.
UNCKA	ı	FIFO A unload clock. Data is read from FIFO A on a low-to-high transition of UNCKA when EMPTYA is high.
UNCKB	ı	FIFO B unload clock. Data is read from FIFO B on a low-to-high transition of UNCKB when EMPTYB is high.



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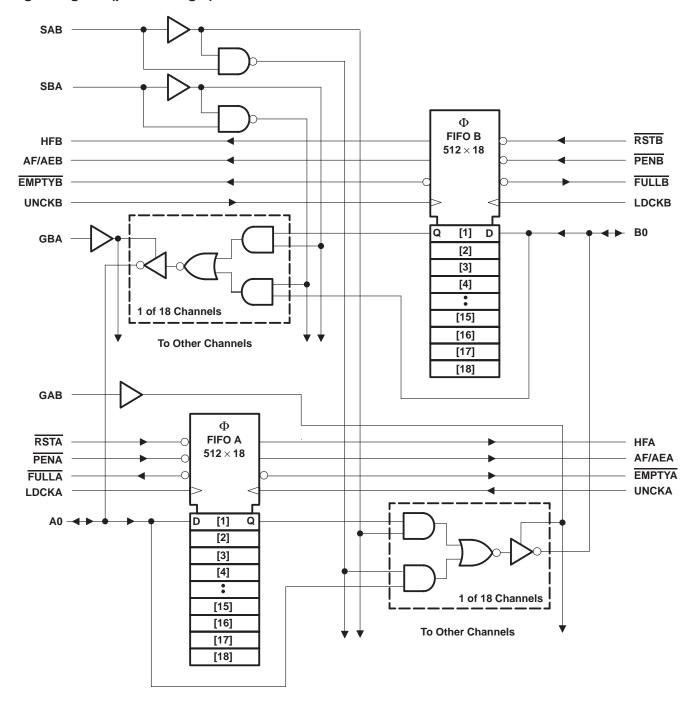
### logic symbol<sup>†</sup>



<sup>†</sup> This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.



## logic diagram (positive logic)



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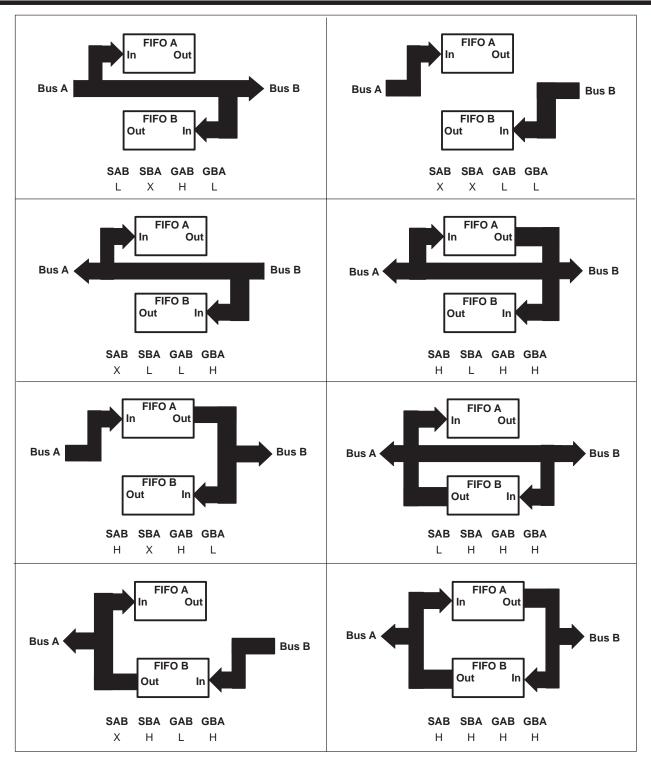


Figure 1. Bus-Management Functions



# STROBED BIDIRECTIONAL FIRST-IN, FIRST-OUT MEMORY SGBS303E - AUGUST 1994 - REVISED APRIL 2000

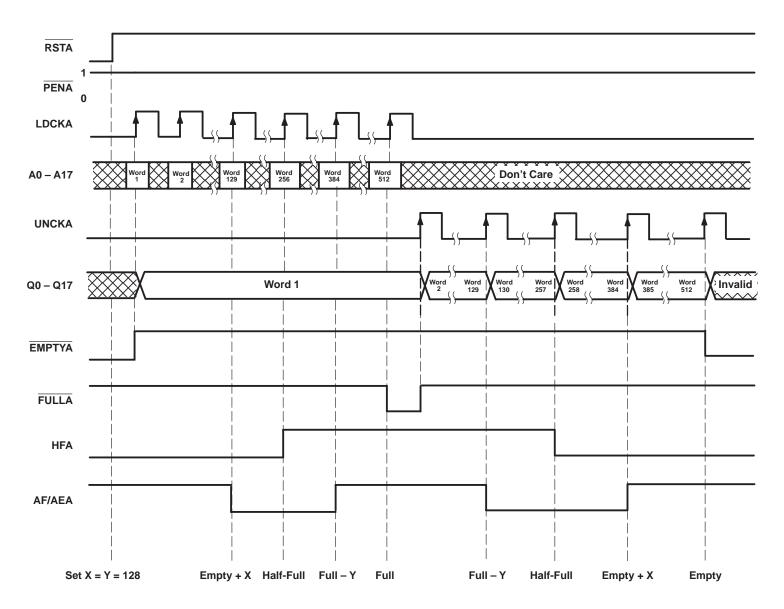
#### SELECT-MODE CONTROL TABLE

CON	TROL	OPERATION				
SBA	SAB	A BUS	B BUS			
L	L	Real-time B to A bus	Real-time A to B bus			
Н	L	FIFO B to A bus	Real-time A to B bus			
L	Н	Real-time B to A bus	FIFO A to B bus			
Н	Н	FIFO B to A bus	FIFO A to B bus			

#### **OUTPUT-ENABLE CONTROL TABLE**

CON	TROL	OPERATION				
GBA	GAB	A BUS	B BUS			
L	L	Isolation/input to A bus	Isolation/input to B bus			
Н	L	A bus enabled	Isolation/input to B bus			
L	Н	Isolation/input to A bus	B bus enabled			
Н	Н	A bus enabled	B bus enabled			

Figure 1. Bus-Management Functions (Continued)



<sup>&</sup>lt;sup>†</sup> SAB = GAB = H, GBA = L Operation of FIFO B is identical to that of FIFO A.

Figure 2. Timing Diagram for FIFO A

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### offset values for almost-full/almost-empty (AF/AE) flag

The AF/AE flag of each FIFO has two programmable limits: the almost-empty offset value (X) and the almost-full offset value (Y). The offsets of a flag can be programmed from the input of its FIFO after it is reset and before any data is written to its memory. An AF/AE flag is high when its FIFO contains X or fewer words or (512 - Y) or more words.

To program the offset values for AF/AEA,  $\overline{PENA}$  can be brought low after FIFO A is reset and only when LDCKA is low. On the following low-to-high transition of LDCKA, the binary value on A0–A7 is stored as the almost-empty offset value (X) and the almost-full offset value (Y). Holding  $\overline{PENA}$  low for another low-to-high transition of LDCKA reprograms Y to the binary value on A0–A7 at the time of the second LDCKA low-to-high transition.

PENA can be brought back high only when LDCKA is low during the first two LDCKA cycles. PENA can be brought high at any time after the second LDCKA pulse returns low. A maximum value of 255 can be programmed for either X or Y (see Figure 3). To use the default values of X = Y = 128 for AF/AEA, PENA must be tied high. No data is stored in the FIFO when its AF/AE offsets are programmed.

The AF/AEB flag is programmed in the same manner. PENB enables LDCKB to program the AF/AEB offset values taken from B0-B7.

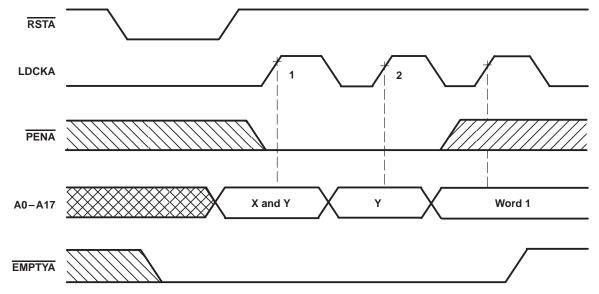


Figure 3. Programming X and Y Separately for AF/AEA

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## absolute maximum ratings over operating free-air temperature (unless otherwise noted)†

Supply voltage range, V <sub>CC</sub>	0.5 V to 7 \
Input voltage range, V <sub>I</sub> (see Note 1)	
Voltage range applied to any output in the high state or power-off state, $V_{O}$	0.5 V to 5.5 \
Current into any output in the low state, IO	48 m/
Input clamp current, I <sub>IK</sub> (V <sub>I</sub> < 0)	–18 m/
Output clamp current, I <sub>OK</sub> (V <sub>O</sub> < 0)	
Storage temperature range. T <sub>eta</sub>	65°C to 150°C

### recommended operating conditions

		MIN	NOM	MAX	UNIT
Vcc	Supply voltage	4.5	5	5.5	V
VIH	High-level input voltage	2			V
$V_{IL}$	Low-level input voltage			0.8	V
٧ <sub>I</sub>	Input voltage	0		VCC	V
ЮН	High-level output current			-12	mA
loL	Low-level output current			24	mA
Δt/Δν	Input transition rise or fall rate			5	ns/V
TA	Operating free-air temperature	-55		125	°C

# electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PAI	RAMETER		TEST C	ONDITIONS		MIN	TYP‡	MAX	UNIT
VIK		$V_{CC} = 4.5 \text{ V},$	$I_{ } = -18 \text{ mA}$					- 1.2	V
		$V_{CC} = 4.5 \text{ V}, \qquad I_{OH} = -3 \text{ mA}$							
Vон		V <sub>CC</sub> = 5 V,	3			V			
		$V_{CC} = 4.5 \text{ V},$	I <sub>OH</sub> = - 12 n	nA		2			
VOL		$V_{CC} = 4.5 \text{ V},$	I <sub>OL</sub> = 24 mA					0.55	V
IĮ		$V_{CC} = 5.5 \text{ V},$	$V_I = V_{CC}$ or	GND				±5	μΑ
I <sub>OZH</sub> §		$V_{CC} = 5.5 \text{ V},$	$V_0 = 2.7 \text{ V}$					50	μΑ
l <sub>OZL</sub> §		V <sub>CC</sub> = 5.5 V,	V <sub>O</sub> = 0.5 V					- 50	μΑ
IO¶		V <sub>CC</sub> = 5.5 V,	V <sub>O</sub> = 2.5 V			- 40	- 100	- 180	mA
					Outputs high			15	
Icc		$V_{CC} = 5.5 V$ ,		$V_I = V_{CC}$ or GND	Outputs low			95	mA
					Outputs disabled			15	
Ci	Control inputs	V <sub>I</sub> = 2.5 V or 0.5 V					6		pF
Co	Flags	V <sub>O</sub> = 2.5 V or 0.5 V					4		pF
C <sub>io</sub>	A or B ports	V <sub>O</sub> = 2.5 V or 0.5 V			·		8		pF

<sup>‡</sup> All typical values are at  $V_{CC} = 5 \text{ V}$ ,  $T_A = 25^{\circ}\text{C}$ .



<sup>†</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTE 1: The input and output negative-voltage ratings may be exceeded if the input and output clamp-current ratings are observed.

<sup>§</sup> The parameters IOZH and IOZL include the input leakage current.

<sup>¶</sup> Not more than one output should be tested at a time, and the duration of the test should not exceed one second.

# STROBED BIDIRECTIONAL FIRST-IN, FIRST-OUT MEMORY SGBS303E – AUGUST 1994 – REVISED APRIL 2000

### timing requirements over recommended operating free-air temperature range (unless otherwise noted) (see Figure 4)

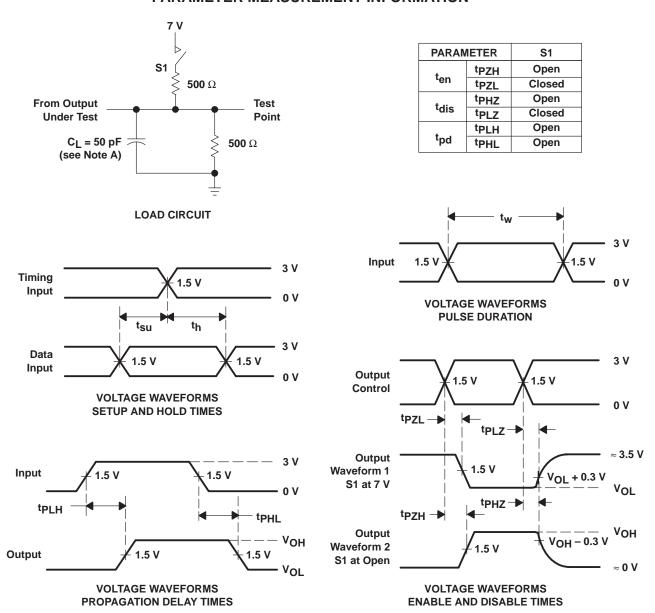
			MIN	MAX	UNIT
fclock	Clock frequency			40	MHz
		LDCKA, LDCKB high	9		
		LDCKA, LDCKB low	9		
t <sub>W</sub>	Pulse duration	UNCKA, UNCKB high	9		ns
		UNCKA, UNCKB low	9		
		RSTA, RSTB low	10		
		A0-A17 before LDCKA↑ and B0-B17 before LDCKB↑	4		
t <sub>su</sub>	Setup time	PENA before LDCKA↑ and PENB before LDCKB↑	6		ns
		LDCKA inactive before RSTA high and LDCKB inactive before RSTB high	4		
		A0−A17 after LDCKA↑ and B0−B17 after LDCKB↑	0		
t <sub>h</sub>	Hold time	PENA after LDCKA low and PENB after LDCKB low	3		ns
		LDCKA inactive after RSTA high and LDCKB inactive after RSTB high	4		

# switching characteristics over recommended ranges of supply voltage and operating free-air temperature, $C_L$ = 50 pF (unless otherwise noted) (see Figure 4)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	MIN	MAX	UNIT
f <sub>max</sub>	LDCK, UNCK		40		MHz
4 .	LDCKA↑, LDCKB↑	B/A	3	18	
<sup>t</sup> pd	UNCKA↑, UNCKB↑	B/A	3	15	ns
<sup>t</sup> PLH	LDCKA↑, LDCKB↑	EMPTYA, EMPTYB	3	17	ns
	UNCKA↑, UNCKB↑	EMPTY/ EMPTY/	3	16	
<sup>t</sup> PHL	RSTA low, RSTB low	EMPTYA, EMPTYB	5	18	ns
	LDCKA↑, LDCKB↑	FULLA, FULLB	5	16	1
	UNCKA↑, UNCKB↑		5	17	
<sup>t</sup> PLH	RSTA low, RSTB low	FULLA, FULLB	7	22	ns
4 .	LDCKA↑, LDCKB↑	AE/AEA AE/AEB	7	18	
<sup>t</sup> pd	UNCKA↑, UNCKB↑	AF/AEA, AF/AEB	7	18	ns
4	RSTA low, RSTB low	AF/AEA, AF/AEB	1	16	
<sup>t</sup> PLH	LDCKA↑, LDCKB↑	HFA, HFB	6	17	ns
<b>4-</b>	UNCKA, UNCKB	LIEA LIEB	7	17	
<sup>t</sup> PHL	RSTA low, RSTB low	HFA, HFB	1	16	ns
+ .	SAB/SBA <sup>†</sup>	B/A	1	12	ns
<sup>t</sup> pd	A/B	D/A	1	11	
t <sub>en</sub>	GBA/GAB	A/B	1	10	ns
t <sub>dis</sub>	GBA/GAB	A/B	1	13	ns

<sup>†</sup> These parameters are measured with the internal output state of the storage register opposite that of the bus input.

#### PARAMETER MEASUREMENT INFORMATION



NOTE A: C<sub>L</sub> includes probe and jig capacitance.

Figure 4. Load Circuit and Voltage Waveforms

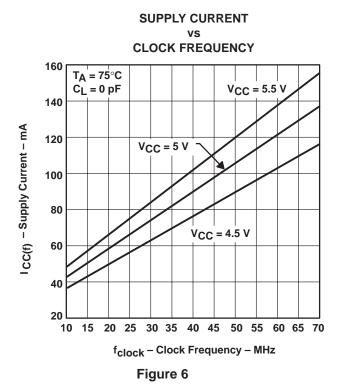


# STROBED BIDIRECTIONAL FIRST-IN, FIRST-OUT MEMORY SGBS303E - AUGUST 1994 - REVISED APRIL 2000

### **TYPICAL CHARACTERISTICS**

## PROPAGATION DELAY TIME **LOAD CAPACITANCE** $V_{CC} = 5 V$ $T_A = 25^{\circ}C$ typ + 6 $R_L = 500 \Omega$ tpd - Propagation Delay Time - ns typ + 4 typ + 2 typ typ - 2 0 50 100 150 200 250 300 C<sub>L</sub> - Load Capacitance - pF

Figure 5



5-Sep-2011

#### **PACKAGING INFORMATION**

Orderable Device	Status <sup>(1)</sup>	Package Type	e Package Drawing	Pins	Package Qty	Eco Plan <sup>(2)</sup>	Lead/ Ball Finish	MSL Peak Temp <sup>(3)</sup>	Samples (Requires Login)
5962-9650901QXA	ACTIVE	CPGA	GB	84	1	TBD	Call TI	Call TI	
SNJ54ABT7820GB	ACTIVE	CPGA	GB	84	1	TBD	POST-PLATE	N / A for Pkg Type	

(1) The marketing status values are defined as follows:

**ACTIVE:** Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

**TBD:** The Pb-Free/Green conversion plan has not been defined.

**Pb-Free (RoHS):** TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

**Pb-Free (RoHS Exempt):** This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

(3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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#### OTHER QUALIFIED VERSIONS OF SN54ABT7820:

Catalog: SN74ABT7820

NOTE: Qualified Version Definitions:





5-Sep-2011

Catalog - TI's standard catalog product

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